SCBS7	727	′ —	JU	LY	200	0

<ul> <li>BiCMOS Technology With Low Quiescent Power</li> </ul>		CKAGE VIEW)
Buffered Inputs		
Noninverted Outputs	1D 🛛 2	23 1Q
<ul> <li>Input/Output Isolation From V<sub>CC</sub></li> </ul>	2D 🛛 3	22 2Q
Controlled Output Edge Rates	3D [ 4	21 3Q
48-mA Output Sink Current		20 4Q
<ul> <li>Output Voltage Swing Limited to 3.7 V</li> </ul>	5D [ 6 6D [ 7	19 5Q 18 6Q
SCR Latch-Up-Resistant BiCMOS Process	7D [] 8	17 7Q
and Circuit Design	8D 🛛 9	16 8Q
<ul> <li>Packaged in Plastic Small-Outline Package</li> </ul>	9D [ 10	15 9Q
	CLR 11	14 PRE
description	GND [12	13 LE

The CD74FCT843A is a 9-bit, bus-interface,

D-type latch with 3-state outputs, designed

specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The device uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below  $V_{CC}$ . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes  $V_{CC}$  bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 mA.

The CD74FCT843A outputs are transparent to the inputs when the latch-enable (LE) input is high. The latches are transparent D-type latches. When LE goes low, the data is latched. The output-enable ( $\overline{OE}$ ) input controls the 3-state outputs. When  $\overline{OE}$  is high, the outputs are in the high-impedance state. The latch operation is independent of the state of the output enable. This device, having preset ( $\overline{PRE}$ ) and clear ( $\overline{CLR}$ ), are ideal for parity-bus interfacing. When  $\overline{PRE}$  is low, the outputs are high if  $\overline{OE}$  is low.  $\overline{PRE}$  overrides  $\overline{CLR}$ . When  $\overline{CLR}$  is low, the outputs are low if  $\overline{OE}$  is low. When  $\overline{CLR}$  is high, data can be entered into the latch. The device provides noninverted outputs.

OE does not affect the internal operations of the latch. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

The CD74FCT843A is characterized for operation from 0°C to 70°C.

			TON TAE		
		INPUTS			OUTPUT
PRE	CLR	OE	LE	D	Q
L	Х	L	Х	Х	Н
н	L	L	Х	Х	L
н	н	L	н	L	L
н	н	L	н	Н	н
н	Н	L	L	Х	Q <sub>0</sub> Z
Х	Х	Н	Х	Х	Z



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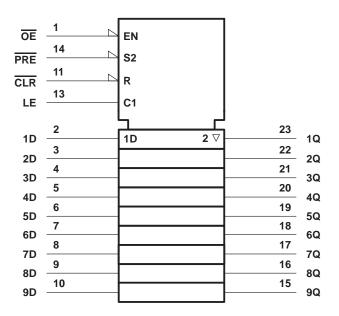
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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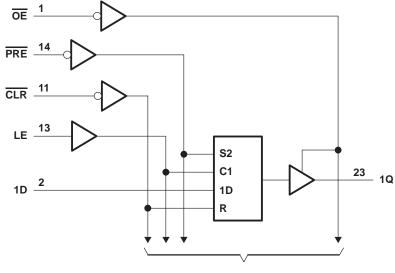
#### CD74FCT843A BiCMOS 9-BIT BUS-INTERFACE D-TYPE LATCH WITH 3-STATE OUTPUTS SCBS727 - JULY 2000

### logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagram (positive logic)



**To Eight Other Channels** 



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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

DC supply voltage range, $V_{CC}$	-20 mA -50 mA . 70 mA -30 mA 237 mA 453 mA 46°C/W
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

#### recommended operating conditions (see Note 2)

		MIN	MAX	UNIT
VCC	Supply voltage	4.75	5.25	V
VIH	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
VO	Output voltage	0	VCC	V
ЮН	High-level output current		-15	mA
IOL	Low-level output current		48	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
Т <sub>А</sub>	Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## electrical characteristics over recommended operating temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vee	T <sub>A</sub> = 25°C	MIN MAX	UNIT
PARAMIETER	TEST CONDITIONS	Vcc	MIN MAX		
VIK	II = -18 mA	4.75 V	-1.2	-1.2	V
VOH	$I_{OH} = -15 \text{ mA}$	4.75 V	2.4	2.4	V
V <sub>OL</sub>	I <sub>OL</sub> = 48 mA	4.75 V	0.55	0.55	V
lı	$V_{I} = V_{CC}$ or GND	5.25 V	±0.1	±1	μA
I <sub>OZ</sub>	$V_{O} = V_{CC}$ or GND	5.25 V	±0.5	±10	μA
los‡	$V_{I} = V_{CC} \text{ or GND}, \qquad V_{O} = 0$	5.25 V	-75	-75	mA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.25 V	8	80	μA
∆ICC§	One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.25 V	1.6	1.6	mA
Ci	$V_{I} = V_{CC}$ or GND		10	10	pF
Co	$V_{O} = V_{CC} \text{ or } GND$		15	15	pF

<sup>‡</sup>Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.

§ This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.



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## timing requirements over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

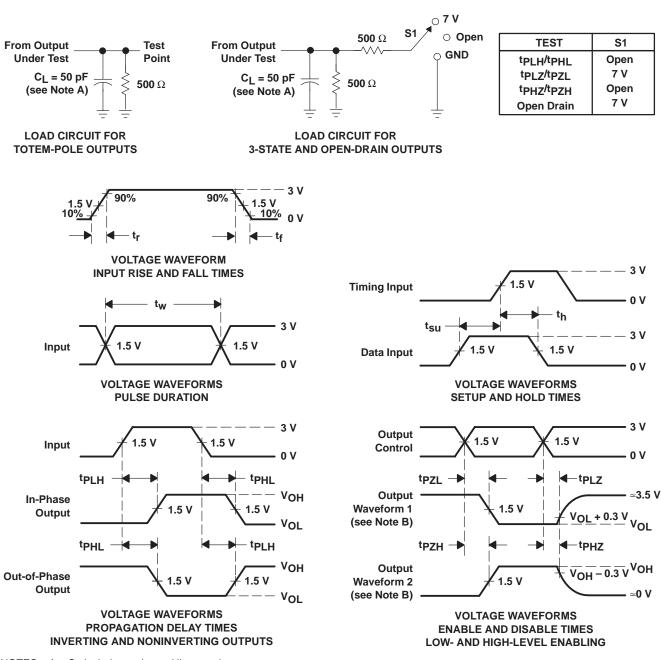
			MIN	MAX	UNIT
		CLR low	8		
t <sub>w</sub> Puls	Pulse duration	PRE low	8		ns
		LE low	4		
		Data before LE $\downarrow$	2.5 1.4		ns
t <sub>su</sub>	Setup time	PRE inactive			
		CLR inactive	1.4		
t <sub>h</sub>	Hold time	Data before LE $\downarrow$	2.5		ns
t <sub>rec</sub>	Recovery time	PRE, CLR	14		ns

# switching characteristics over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T <sub>A</sub> = 25°C TYP	MIN	МАХ	UNIT
• •	D		6.8	1.5	9	ns
<sup>t</sup> pd	LE	Q	9	1.5	12	
<sup>t</sup> PLH	PRE	Q	9	1.5	12	ns
<sup>t</sup> PHL	CLR	Q	9.8	1.5	13	ns
ten	OE	Q	10.5	1.5	14	ns
<sup>t</sup> dis	OE	Q	6	1.5	8	ns

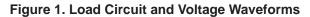


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### PARAMETER MEASUREMENT INFORMATION

- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics:  $PRR \le 1$  MHz,  $Z_O = 50 \Omega$ ,  $t_f$  and  $t_f = 2.5$  ns. D. The outputs are measured one at a time with one input transition per measurement.
  - D. The outputs are measured one at a time
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
  - G. tPHL and tPLH are the same as tpd.





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#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins I	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
CD74FCT843AM	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74FCT843AME4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74FCT843AMG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

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PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

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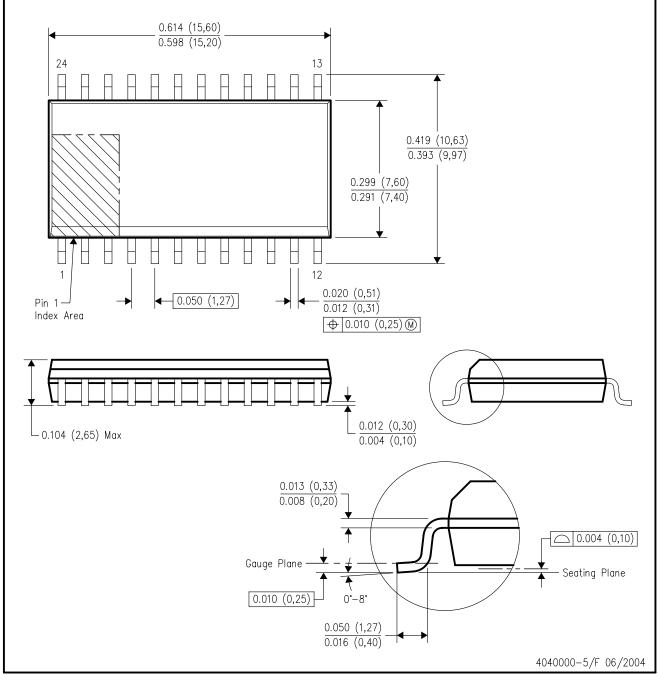
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DW (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



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